

Vishay Siliconix

AUTOMOTIVE

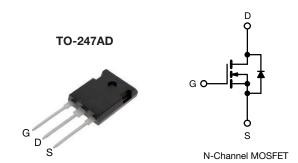
RoHS

COMPLIANT

HALOGEN FREE

# **Automotive E Series Power MOSFET with Fast Body Diode**

PRODUCT SUMMARY				
V <sub>DS</sub> (V) at T <sub>J</sub> max.	700			
R <sub>DS(on)</sub> typ. at 25 °C (Ω)	V <sub>GS</sub> = 10 V	0.045		
Q <sub>g</sub> typ. (nC)	229			
Q <sub>gs</sub> (nC)	53			
Q <sub>gd</sub> (nC)	91			
Configuration	Single			



#### **FEATURES**

 Fast body diode MOSFET using Automotive Grade E series technology



• Low figure-of-merit (FOM) Ron x Qa

Low input capacitance (C<sub>iss</sub>)

• Low switching losses due to reduced Q<sub>rr</sub>

• 175 °C operating temperature

- AEC-Q101 qualified
- Ultra low gate charge (Q<sub>a</sub>)
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



- · Automotive onboard charger
- Automotive DC/DC converter

ORDERING INFORMATION			
Package	TO-247AD		
Lead (Pb)-Free and Halogen-Free	SQW61N65EF-GE3		

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	650	V	
Gate-Source Voltage			$V_{GS}$	± 30		
Continuous Drain Current (T <sub>J</sub> = 175 °C)		V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	62	А
			$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		44	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	187		
Linear Derating Factor				4.2	W/°C	
Single Pulse Avalanche Energy b			E <sub>AS</sub>	1323	mJ	
Maximum Power Dissipation				$P_{D}$	625	W
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Drain-Source Voltage Slope			dV/dt	70	\//	
Reverse Diode dV/dt <sup>d</sup>				50	V/ns	
Soldering Recommendations (Peak temperature	re) <sup>c</sup>	For	10 s		260	°C

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature
- b.  $V_{DD}$  = 140 V, starting  $T_J$  = 25 °C, L = 73.5 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 6 A
- c. 1.6 mm from case
- d.  $I_{SD} \le I_D$ , di/dt = 470 A/ $\mu$ s, starting  $T_J$  = 25 °C



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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	LIMIT	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	40	°C/W	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	0.24	G/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static					•		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	650	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	-	0.77	-	V/°C	
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	2.0	-	4.0	V	
0.1. 0		V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 30 V			± 1	μΑ
Zava Cata Valtaga Drain Current		V <sub>DS</sub> = 520 V, V <sub>GS</sub> = 0 V		-	-	1	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 520 V	V <sub>DS</sub> = 520 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	500	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 32 A	-	0.045	0.052	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 30 V, I <sub>D</sub> = 32 A		-	28	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 100 V, f = 1 MHz		-	7379	-	pF
Output Capacitance	Coss			-	310	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	4	-	
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	V <sub>DS</sub> = 0 V to 520 V, V <sub>GS</sub> = 0 V		-	213	-	
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	841	-	
Total Gate Charge	Qg			-	229	344	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 32 \text{ A}, V_{DS} = 520 \text{ V}$		-	53	-	nC
Gate-Drain Charge	Q <sub>gd</sub>				91	-	
Turn-On Delay Time	t <sub>d(on)</sub>			-	65	98	
Rise Time	t <sub>r</sub>	$V_{DD} = 520 \text{ V}, I_{D} = 32 \text{ A}, V_{GS} = 10 \text{ V}, R_{g} = 9.1 \Omega$		-	107	161	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	252	378	
Fall Time	t <sub>f</sub>			-	102	153	
Gate Input Resistance	$R_g$	f = 1 MHz, open drain		0.5	1	2	Ω
Drain-Source Body Diode Characteristics	S						
Continuous Source-Drain Diode Current	Is	MOSFET sym	MOSFET symbol		-	62	
Pulsed Diode Forward Current	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	187	Α
Diode Forward Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 32  \text{A},  V_{GS} = 0  \text{V}$		-	0.9	1.2	V
Reverse Recovery Time	t <sub>rr</sub>				204	408	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25 ^{\circ}\text{C}$ , $I_F = I_S = 30.5 \text{A}$ , $di/dt = 100 \text{A/}\mu\text{s}$ , $V_R = 400 \text{V}$		-	1.9	3.8	μC
Reverse Recovery Current	I <sub>RRM</sub>			-	18	-	Α

### Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$
- b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

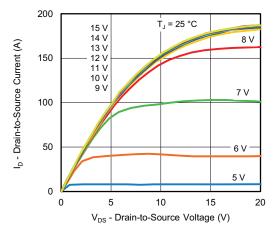


Fig. 1 - Typical Output Characteristics

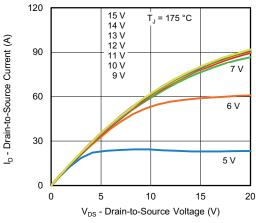


Fig. 2 - Typical Output Characteristics

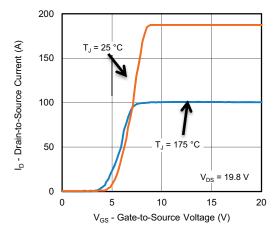


Fig. 3 - Typical Transfer Characteristics

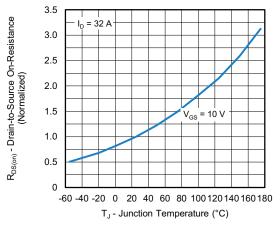


Fig. 4 - Normalized On-Resistance vs. Temperature

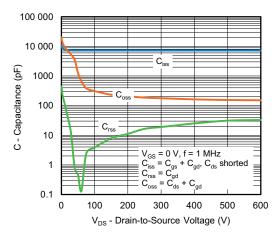


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

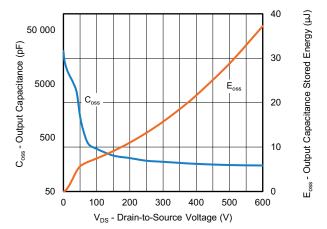


Fig. 6 - Coss and Eoss vs. VDS



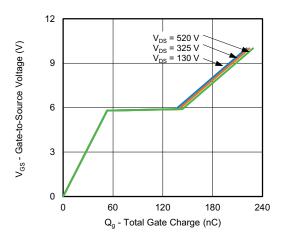


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

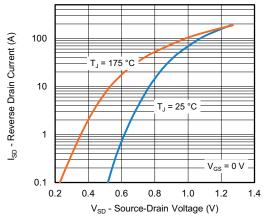


Fig. 8 - Typical Source-Drain Diode Forward Voltage

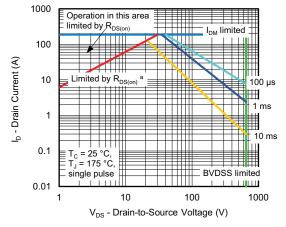


Fig. 9 - Maximum Safe Operating Area



a.  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

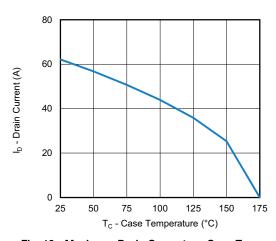


Fig. 10 - Maximum Drain Current vs. Case Temperature

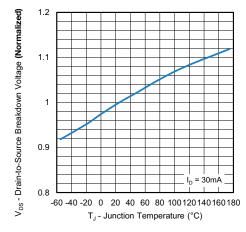


Fig. 11 - Temperature vs. Drain-to-Source Voltage



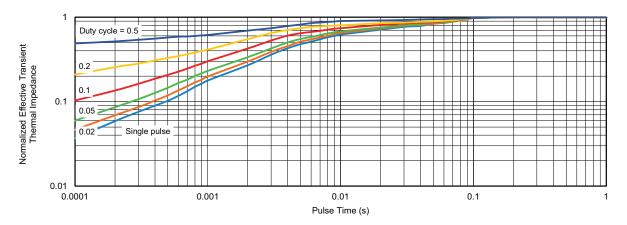


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

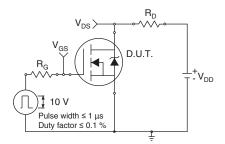


Fig. 13 - Switching Time Test Circuit

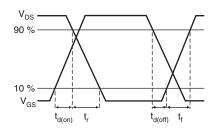


Fig. 14 - Switching Time Waveforms

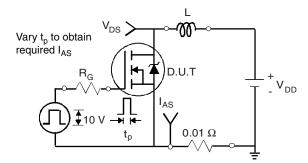


Fig. 15 - Unclamped Inductive Test Circuit

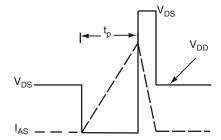


Fig. 16 - Unclamped Inductive Waveforms

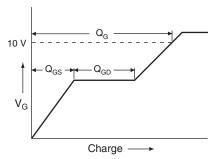


Fig. 17 - Basic Gate Charge Waveform

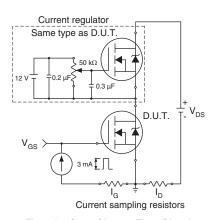
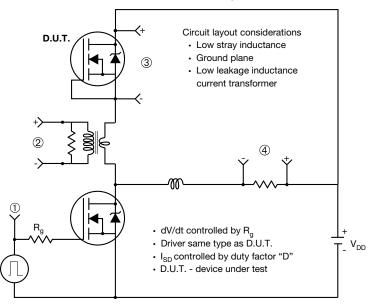


Fig. 18 - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



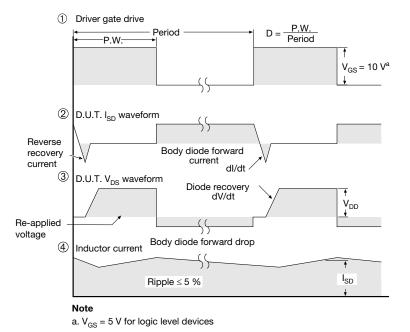


Fig. 19 - For N-Channel

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